Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/705,776 <sup>-</sup>	CRUCHON-DUPEYRAT ET AL.
Examiner	Art Unit
Huan H. Tran	2861

SEARCHED			
Class	Subclass	Date	Examiner
	,		
<u> </u>			
			`

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		· · · · ·	

SEARCH (INCLUDING SEAF		iY)
	DATE	EXMR
EAST	9/2/2005	ннт
Interference search	10/28/200	5 ННТ